

<b>Notice of References Cited</b>	Application/Control No. 10/821,909	Applicant(s)/Patent Under Reexamination DOI, YOSHIAKI	
	Examiner Hieu Nguyen	Art Unit 2817	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-			
	D	US-			
	E	US-			
	F	US-			
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